## Abstract Submitted for the TSF12 Meeting of The American Physical Society

Theoretical Study of the Structural and Electronic Properties of  $K_x Si_{136}$ , (x = 1, 8, 18) CRAIG HIGGINS, CHARLES MYLES, Texas Tech University, TEXAS TECH TEAM — Type II clathrate semiconductors have cage-like lattices in which Group IV atoms are tetrahedrally-coordinated and sp<sup>3</sup> covalently bonded. The cages can contain "guest" atoms; usually alkali or alkaline earth atoms. These materials are of interest because of their thermoelectric properties. Measurements of the lattice constant [1] as a function of Na concentration x in Na<sub>x</sub>Si<sub>136</sub> (0  $\leq$  $x \leq 24$ ) have shown the interesting property that, as x is increased in the range ( $0 \leq 1$ )  $x \leq 8$ ), the lattice constant decreases and that as x is increased further in the range  $(8 \le x \le 24)$ , the lattice constant increases. We note that some measurements of the properties of  $K_{17.8}Si_{136}$  have also recently been reported [2]. These observations have motivated us to study the behavior of the lattice constant and other properties as a function of guest concentration in other Type II clathrates. In the present paper, we report the results of a theoretical study of the properties of  $K_x Si_{136}$  as a function of x. We have used density functional theory to investigate the properties of this material with guest concentrations of x = 1, 8, and 18. Our results show that, similar to previous results for  $Na_xSi_{136}$ , the lattice constant as a function of x has a minimum at x = 8. We also report results for other structural and electronic properties of  $K_x Si_{136}$ .

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